

(REV. 05/03)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)

ATTY. DOCKET NO.

MAIT-003AX

(Formerly
301505.3002-103)

APPLICATION NO.

10/823,389

APPLICANT:

Christopher M. Fang-Yen, *et al.*

FILING DATE

April 13, 2004


TC ART UNIT

2877

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	PUBLICATION/ ISSUE DATE	NAME	CLASS	SUBCLASS	FILING DATE
IPC/	US 3,970,389	20 July 1976	Mendrin, <i>et al.</i>	357	106	
	US 4,702,603	27 Oct 1987	Augustyn	356	351	
	US 4,756,611	12 Jul 1988	Yonekubo, <i>et al.</i>	350	509	
	US 4,938,584	3 July 1990	Suematsu, <i>et al.</i>	351	211	
	US 5,018,862	28 May 1991	Aiello	356	358	
	US 5,124,927	23 Jun 1992	Hopewell, <i>et al.</i>	364	468	
	US 5,153,669	6 Oct 1992	DeGroot	356	349	
	US 5,263,776	23 Nov 1993	Abraham, <i>et al.</i>	374	16	
	US 5,349,440	20 Sep 1994	DeGroot	356	349	
	US 5,371,587	6 Dec 1994	DeGroot, <i>et al.</i>	356	349	
	US 5,404,221	4 Apr 1995	DeGroot	356	349	
	US 5,412,474	2 May 1995	Reasenbergs, <i>et al.</i>	356	349	
	US 5,430,814	4 Jul 1995	McCall, <i>et al.</i>	385	12	
	US 5,446,540	29 Aug 1995	Lin	356	345	
	US 5,450,501	12 Sep 1995	Smid	382	260	
	US 5,543,914	6 Aug 1996	Henshaw, <i>et al.</i>	356	345	
	US 5,550,887	27 Aug 1996	Schmal, <i>et al.</i>	378	43	
	US 5,579,109	26 Nov 1996	Suh, <i>et al.</i>	356	349	
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	SU 1357712 A1	7 Dec 1997	Russia (Abstract)				
	EP 0 932 050 A2	4 Dec 1998	Europe (Abstract)				
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EXAMINER		/Patrick Connolly/ DATE CONSIDERED (05/14/2007)	
*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.			

****The art was cited in PCT International Search Report mailed July 4, 2003 in International Application No. PCT/US02/40440 filed December 12, 2002.**